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2012.07.09

Kunshan Jiahua Electronics Co., Ltd.

文件名称 System Name:	产品品名 Description:	文件	文件编号 Document No.:		lo.:
		PS-0063			
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***** Revised history *****

Edition	ECN NO.	Revised Page	Remark
1	ECN1207045	None	Initial Release



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1. 概述 Scope:

1.1 说明 Content

此份产品规格书是针对由昆山嘉华电子有限公司设计和制造的 Micro SD 1.32H CONN.产品所定义的产品性能和测试方法。

This product specification defines the product performance and the test methods to ensure the performance of the **Micro SD 1.32H CONN.**, which is designed and manufactured by Kunshan Jiahua Electronics Co., Ltd.

1.2 限制 Qualification

所有的测试和检验必须依照本文件中所要求的规格、方法进行。一旦产品的重要制程发生 变更,必须立即进行品质验证和测试。

Tests and inspection shall be performed in accordance with the requirements, tests and methods contained herein. A re-qualification test shall be conducted immediately following all major process changes.

2. 参考文件 Referenced Documents:

EIA364

MIL-STD-883B: Methods 2022 solder Testing.

ISO 7816-1:Identification Cards-integrated circuit cards with contact-dimension and location of the contacts.

GSM11.11:IETS subscriber identity module-interface specification EIA 481-3 ,SMD tapping standard

若某些项目被发现本规格书中的内容与以上参考文件要求不一致时,一律依本规格书中的内容为测试依据。

In case of any contradiction between this document and referenced documents, this document will take precedence.

保管单位:产品工程 保存期限:该产品停产后1日历年 文件编号:QP-07-04/09A



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3. 规格要求 Requirements:

3.1 应用条件 Application Condition:

3.1.1 额定电流: 0.5Amps DC Max. per contact

CURRENT RATING: 0.5Amps DC Max. per contact

3.1.2 额定电压: 100 Volt DC Max.

VOLTAGE RATING: 100 Volt DC Max

3.1.3 使用环境 Operating Environment:

温度: -25°C to +85°C,相对湿度:25%~85%,此条件下功能不可失效。

Temperature:-25°C to +85°C, Relative Humidity:25%~85%, Without loss of function.

3.1.4 储存环境 Storage Environment:

温度: -40°C to +85°C,相对湿度:25%~85%或更低,此条件下功能不可失效。

Temperature:-40°C to +85°C, Relative Humidity: 25%~85% or Less, Without loss of function.

3.2 绿色环保要求 Health, Safety and Environment

此产品中所有涉及环保有关的有害物质管控标准请参考嘉华系统文件:JH-GP-213

Hazardous substances (Environment related to be controlled substances) contained in this product should comply with the regulations specified by FAF's **JH-GP-213**.

3.3 测试说明 Test Description

此产品性能须满足本文件第 4 节中的各项规格要求。除非有特别申明,所有的测试和量测必须在以下条件中进行:

The product is designed to meet the requirements specified in section 3.4. Unless otherwise specified, all tests and measurements are to be performed under the following conditions:

温度 Temperature: 15 to 35℃

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相对湿度 Relative Humidity: 25% to 75%

大气压 Atmospheric Pressure: 650 to 800 millimeters (25.6 to 31.5 inches) of Mercury.

3.4 电镀要求:

3.4.1 电镀厂商: 常熟永新;

3.4.2 电镀线体: 一机两线连续电镀线, J 号线;

3.4.3 不作用任何封孔处理;

4.测试规范和方法 Test Requirements and Methods

项目 Items	规格要求 Requirements	测试方法 Test Methods
4.1 产品外观和尺寸检查	所有零件必须组装完好,不能出现毛边,变形,刮伤,以及任何外观破坏等异常;	依照相应的文件和规格书进行外观,功能,及尺寸的检验量测.
Appearance	All components shall be properly assembled and free of burrs, warps, scratches, broken chips, and other abnormalities	Visual, functional, and dimensional inspection complies with applicable specification and document.
4.2 电气 性能 Electri 4.2.1 接触阻抗	cal Performance : 初始接触阻抗: 100mΩMax;	测量接触阻抗,测试电流小于 10mA
女熈阻机 Low level contact resistance	试验后接触阻抗:变化值 $40m\Omega$ Max; Initial: $100m\Omega$ Max;	Measure contact resistance of product and test card PCB with less than current of 10 mA (exception for the conductor resistance)
	After test: 40 m Ω Max Change	
4.2.2	初始绝缘阻抗: 1000 MΩ Min	测试电压: 直流 500V , 测试时间: 1分
绝缘阻抗 Insulation resistance	试验后绝缘阻抗: 100 MΩ Min Initial:1000 MΩ Min After test:100 MΩ Min	钟,测试相邻两端子之间的绝缘阻抗 Give DC 500V Voltage for 1 minutes and then measure insulation resistance of contact and contact

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4.2.3 耐电压 Dielectric withstanding voltage	产品既无电火花也无气体产生 漏电流最大 0.5mA After the test, Neither creeping discharge nor flashover shall occur. Leakage current 0.5 mA Max	两相邻端子之间加载交流 500V 电压 1 分钟; Give AC 500 V in near contact and insulator for 1 minute
4.2.4 温升 Temperature Rise	温度升高不超过 30 ℃; Temperature Rise 30 ℃ Max;	产品插卡后当额定电流通过时,测试端子之 温度升高; Mate card and measure the temperature rise of contact,when rated current is passed
4.3 机械 性能 Mechai	ical Performance :	
4.3.1 插卡力 Insertion force	插入力: 40N Max; Insertion force: 40N Max;	产品焊板后,测量卡片插入力,测试速度: 25±3mm/min After Soldering of testing product at PCB, Measure insertion force of Plug at 25±3mm/min;
4.3.2 拔卡力 Pulling force	拔卡力: 0.5~40N; Pulling force: 0.5~40N;	产品焊板后,测量卡片拔出力,测试速度: 25±3mm/min After Soldering of testing product at PCB, Measure pulling force of Plug at 25±3mm/min;
4.3.3 耐久 Durability	 试验后接触阻抗:变化值 40mΩMax; 产品无断裂、无破损; Aftertesting,contact resistance: Δ=40 mΩΩMax; No have fracture, crack; 	产品焊板后,重复插拔卡片 10000 次; After Soldering of testing product at PCB, Repeat insert/ withdrawal of card 10000cycles

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4.3.4 振动	1 没有物理损坏,端子无变形 2 不产生超过 1 微秒的瞬断 1No have fracture , crack, terminal	产品焊板后测试, 测试频率: 10-2000Hz	
Vibration	contact point shake of product 2 No electrical discontinuity longer than 1 u sec.	振幅: 1.52mm; Mate card and subjected to the following vibration conditions, for a period of 5 minutes per 1 cycle, 10 cycle per 1 axis total 30 cycles per 3 axis.	
		perpendicular axes, with passing DC	
		1mA during the test.	
		Amplitude: 1.52mm P-P or 19.6m/s2{2G}	
		Frequency: 10-2000Hz. Per EIA-364-28	
		产品插卡后依如下条件测试: 电流: DC 1mA Mate card and subjected to the following shock conditions.	
4.3.5 机械冲击		3 mutually perpendicular axis, passing	
Mechanical Shock	1 没有物理损坏,端子无变形	DC 1mA current during the test.	
	2 不产生超过 1 微秒的瞬断 1No have fracture , crack, terminal	(Total of 18 shocks)	
	contact point shake of product	Test pulse : Half Sine	
	2 No electrical discontinuity longer than 1 u sec.	Peak value : 490m/s2{50G} Duration : 11ms, velocity change 3.44m/s Per EIA-364-27	

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规格要求 Requirements	测试方法 Test Methods
nental Performance :	
 产品无损坏,端子无变形 测试后接触阻抗:变化值 40mΩMax No have fracture crack ,terminal contact point deflection and shake of product After testing contact resistance: Δ=40 mΩ Max 	配合后的产品在以下条件下测试: 温度: 60±2°C; 相对湿度: 90~95% 时间: 96 hours Mated connectors shall be subjected to the following condition: Temperature: 60±2°C Relative humidity: 90 to 95% Period: 96 hours
 产品无损坏,端子无变形; 测试后接触阻抗:变化值 40 mΩMax No have fracture crack, terminal Contact point deflection and shake of product After testing contact resistance: Δ=40 mΩ Max 	<u> </u>
1 产品无损坏,端子无变形 2.试验后接触阻抗:变化值 40 mΩMax 1.No have fracture crack ,terminal contact point deflection and shake of product 2.After testing contact resistance: Δ=40 mΩ Max;	配合后的产品在以下条件下测试: 温度: 85±2°C 时间: 96h Mated connectors shall be subjected to the following condition: temperature: 85±2°C Duration: 96h
	1. 产品无损坏,端子无变形 2. 测试后接触阻抗: 变化值 40mΩMax 1.No have fracture crack ,terminal contact point deflection and shake of product 2. After testing contact resistance: Δ=40 mΩ Max 1. No have fracture crack, terminal Contact point deflection and shake of product 2. After testing contact resistance: Δ=40 mΩ Max 1. No have fracture crack, terminal Contact point deflection and shake of product 2. After testing contact resistance: Δ=40 mΩ Max 1. Phack with the product and shake of product and shake

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4.4.4 热冲击 Thermal shock	测试后满足相应机械及电气规格; 测试后接触阻抗:变化值 $40~m\Omega$ Max After test: Δ = $40~m\Omega$ Max	参考测试标准: EIA-364-32; -55℃和+85℃各 30 分钟,总计 25 个 循环. Comply with method EIA-364-32. -55℃ for 30 minutes and +85℃ for 30 minutes for 25 cycles.
4.4.5 盐雾测试 Salt Spray Test	 产品无损坏,端子无变形 试验后接触阻抗: 变化值 40 mΩMax No have fracture crack ,terminal contact point deflection and shake of product After testing contact resistance: Δ=40 mΩ Max; 	盐水浓度: 5+1%
4.4.6 吃锡性测试 Solder ability	焊脚吃锡面积 95%以上 More than 95% of area dipped in molten solder should be coated by solder	温度: 250℃±5℃ 粘锡时间: 3±0.5 秒 Solder Temperature: 250℃±5℃ Immersion Duration: 3±0.5 seconds
4.4.7 耐 Reflow 高温 Resistance to Reflow Soldering Heat	1.无损坏,端子无变形; 2.产品结构无破坏; 1.No have fracture crack ,terminal contact point deflection and shake of product 2.No have break down outer feature/structure	根据下图温度条件测试产品的耐焊接热 The connector shall be tested resistance to soldering heat in the following conditions, The temperature shall be measured on the surface of PCB Average rampup: 1.8℃/s MAX. Peak temperature 250℃ MAX. Pre-heat temperature 150~200℃



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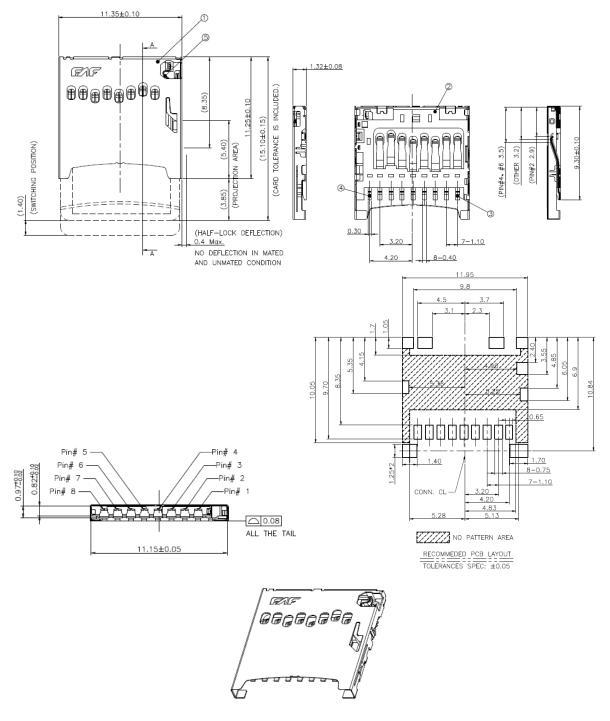
4.5Test Sequence

Group Number	А	В	С	D	E	F	G
Contact Resistance	1,7	1,3,5	1,5,7	1,3,5	1,3		
Insulation Resistance	2,8		2,8				
Dielectric Withstanding Voltage	3,9		3,9				
Temperature Rise							
Insertion force	4,10						
Pulling force	5,11						
Durability	6						
Vibration		2					
Mechanical Shock		4					
High Relative Humidity Exposure			6				
Low Temperature Exposure				2			
High Temperature Exposure				4			
Thermal Shock			4				
Salt Spray Test					2		
Solderability						1	
Resistance to Soldering reflow Heat							1



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5. Product appearance and dimendion:



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